

Application/Control No.	Applicant(s)/Patent under Reexamination
10/577,191	CHEN ET AL.
Examiner	Art Unit
Shin-Lin Chen	1632

SEARCHED				
Class	Subclass	Date	Examiner	
		<b>Duil</b>	2/4/11/10/	
435	4	1/18/2011	SLC	
435	325	1/18/2011	SLC	
435	375	1/18/2011	SLC	
435	377	1/18/2011	SLC	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
435	377	1/18/2011	SLC	
435	4	1/18/2011	SLC	
435	325	1/18/2011	SLC	
435/375		1/18/2011	SLC	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN, Medline, Caplus, Biosis, Scisearch, Lifesci, Inventor name search.	1/18/2011	SLC		